Test Report issued under the responsibility of:



Photobiological safety of lamps and lamp systems         Report Reference No		TEST REPORT IEC 62471
Report Reference No	Photobiological s	-
Date of issue       : 2023-05-14         Total number of pages       : 16         Name of Testing Laboratory preparing Report       SGS-CSTC Standards Technical Services Co., Ltd. Guangzhou the Report         Applicant's name       : Shenzhen Matelight Electronics Co., Ltd.         9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian Distric Shenzhen, China		
Total number of pages       16         Name of Testing Laboratory preparing Branch       SGS-CSTC Standards Technical Services Co., Ltd. Guangzhou Branch         Applicant's name       Shenzhen Matelight Electronics Co., Ltd.         9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian Distric Shenzhen, China       9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian Distric Shenzhen, China         Address       Address       IEC 62471:2006         Test specification:       Test report         Non-standard test method.       N/A         Test Report Form No.       IEC 62471:2006         Test Report Form No.       IEC62471B         TRF Originator.       VDE Testing and Certification Institute         Master TRF       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for admages resulting from the reader's interpretation of the reproduced in dubie or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for admages resulting from the reader's interpretation of the reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material action test.	Report Reference No	GZES200401654431
Name of Testing Laboratory preparing Branch       SGS-CSTC Standards Technical Services Co., Ltd. Guangzhou Branch         Applicant's name       Branch         Applicant's name       Shenzhen Matelight Electronics Co., Ltd.         9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian Distric Shenzhen, China       Address         Address       Address         Test specification:       IEC 62471:2006         Test procedure       Test report         Non-standard test method.       N/A         Test Report Form No.       IEC 62471B         TRF Originator.       VDE Testing and Certification Institute         Master TRF       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for admages resulting from the reader's interpretation of the reproduced material due to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:       The test results present	Date of issue:	2023-05-14
the Report       Branch         Applicant's name       Shenzhen Matelight Electronics Co., Ltd.         9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian District Shenzhen, China       Address         Address       Address         Test specification:       Elec 62471:2006         Test procedure       Test report         Non-standard test method       N/A         Test Report Form No.       IEC 62471B         TRF Originator.       VDE Testing and Certification Institute         Master TRF       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright for and swill not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:       The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testin	Total number of pages:	16
9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian District Shenzhen, China         Address         Address         Test specification:         Standard         Standard         i:       IEC 62471:2006         Test procedure       Test report         Non-standard test method.       N/A         Test Report Form No.       IEC 62471B         TRF Originator.       VDE Testing and Certification Institute         Master TRF       Dated 2018-08-16         Copyright @ 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for ad will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:         The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written approva	• • • • •	•
Shenzhen, China         Address         Test specification:         Standard         Standard         memory         Test procedure         Test procedure         Test report         Non-standard test method.         N/A         Test Report Form No.         IEC 62471B         TRF Originator.         VDE Testing and Certification Institute         Master TRF         Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material use to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:         The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written	Applicant's name:	Shenzhen Matelight Electronics Co., Ltd.
Test specification:         Standard       ::       IEC 62471:2006         Test procedure       ::       Test report         Non-standard test method.       ::       N/A         Test Report Form No.       ::       IEC62471B         TRF Originator.       ::       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:         The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,		9C, 9th Floor, Wenwei Building, No. 322, Fuhua Road, Futian District Shenzhen, China
Standard       ::       IEC 62471:2006         Test procedure       ::       Test report         Non-standard test method       ::       N/A         Test Report Form No.       ::       IEC62471B         TRF Originator       ::       VDE Testing and Certification Institute         Master TRF       ::       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting form the reader's interpretation of the reproduced material due to its placement and context.         If this rest Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:         The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,		Address
Test procedure       Test report         Non-standard test method       N/A         Test Report Form No.       IEC62471B         TRF Originator       VDE Testing and Certification Institute         Master TRF       Dated 2018-08-16         Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved.         This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.         If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.         This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.         General disclaimer:         The test results presented in this report relate only to the object tested.         This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,	Test specification:	NAME AND A DEPARTMENT OF THE DEPARTMENT. THE DEPARTMENT OF THE DEPARTMENT. THE DEPARTMENT OF THE DEPARTMENT. THE DEPARTMENT OF THE DEPARTMENT OF THE DEPARTMENT OF THE DEPARTMENT. THE DEPARTMENT OF THE DEPARTMENT OF THE DEPARTMENT. THE DEPARTMENT OF TH
Non-standard test method       N/A         Test Report Form No	Standard	IEC 62471:2006 电子电气实验室
Test Report Form No	Test procedure:	Test report
TRF Originator	Non-standard test method:	N/A
Master TRF		IEC62471B
Copyright © 2018 IEC System for Conformity Testing and Certification of Electrical Equipment (IECEE), Geneva, Switzerland. All rights reserved. This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context. If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed. This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02. General disclaimer: The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,	TRF Originator :	VDE Testing and Certification Institute
<ul> <li>(IECEE), Geneva, Switzerland. All rights reserved.</li> <li>This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.</li> <li>If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed.</li> <li>This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.</li> <li>General disclaimer:</li> <li>The test results presented in this report relate only to the object tested.</li> <li>This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,</li> </ul>	Master TRF :	Dated 2018-08-16
This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context. If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CE Scheme procedure shall be removed. This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02. General disclaimer: The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,		
Scheme procedure shall be removed. This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02. General disclaimer: The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,	This publication may be reproduced in whole or in p copyright owner and source of the material. IECEE	part for non-commercial purposes as long as the IECEE is acknowledged as takes no responsibility for and will not assume liability for damages resulting from
and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02. General disclaimer: The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,		
The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,		
This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB,	General disclaimer:	
	This report shall not be reproduced, exce Laboratory. The authenticity of this Test F	pt in full, without the written approval of the Issuing CB Testing

Test ite	em description:	SMD LI	ED		
Trade	Mark :	MATELIG	MATELIGHT		
Manufa	cturer :	Same a	me as Applicant		
Model/	Type reference:	MATE	-XXX <sup>®</sup> ; MATE <sup>®</sup> -XXX		
Ratings	S :	R: 20m	A; 1,8 – 2,3 V DC		
		G: 20m	A; 2,8 – 3,5 V DC		
Respo	nsible Testing Laboratory (as app	licable)	, testing procedure and testing	location(s):	
	Testing Laboratory:	S CO.LTD. C	SGS-CSTC Standards Technica Guangzhou Branch	I Services Co., Ltd.	
Testing	glocation/ address	R. S. S.	198 Kezhu Road, Science City, E Bevelopment Area, Guangzhou		
Tested	by (name, function, signature)	读验室	Howord Wang / Project Engineer	Howard Warg	
Approv	ved by (name, function, signature	8W13	Alex Tan / Reviewer	Howard Warg Alex Tan	
	Tooting procedures CTF Store 4				
	Testing procedure: CTF Stage 1:		N/A		
	g location/ address				
	by (name, function, signature)				
Approv	ved by (name, function, signature)	):			
	Testing procedure: CTF Stage 2:		N/A		
Testing	g location/ address	:			
Tested	by (name + signature)	:			
Witnes	sed by (name, function, signature	e):			
Approv	ved by (name, function, signature)	):			
	Testing procedure: CTF Stage 3:		N/A		
	Testing procedure: CTF Stage 4:		N/A		
Testing	g location/ address	:			
Tested	by (name, function, signature)	:			
Witnes	sed by (name, function, signature	e):			
Approv	ved by (name, function, signature)	):			
Superv	rised by (name, function, signatur	re) :			

List of Attachments (including a total number of pages in each attachment): Attachment 1: Photo documentation (total 1 page).			
Summary of testing:			
The test current is 20mA for both colours.			
The green and red light of MATE <sup>①</sup> -XXX <sup>②</sup> were both Group according to IEC 62471: 2006.	tested and found to meet the requirement of Exempt		
<b>Tests performed (name of test and test clause):</b> All applicable test items.	<b>Testing location:</b> 198 Kezhu Road, Science City, Economic & Tech- nology Development Area, Guangzhou, Guangdong, China		
Summary of compliance with National Difference N/A	es (List of countries addressed):		
Copy of marking plate: The artwork below may be only a draft. The use of certification marks on a product must be au- thorized by the respective NCBs that own these marks. —			
Test item particulars			
Tested lamp: 🖾 continuous wave lamps 👘 pulsed lamps			
Tested lamp system:	_		
Lamp classification group	🛛 exempt 🛛 risk 1 🗌 risk 2 🔲 risk 3		
Lamp cap	:		
Bulb: —			
Rated of the lamp			
Furthermore marking on the lamp			
Seasoning of lamps according IEC standard —			
Used measurement instrument			
Temperature by measurement 25 °C $\pm$ 5 °C			
Information for safety use —			

Possible test case verdicts:		
<ul> <li>test case does not apply to the test object: N/A</li> </ul>		
<ul> <li>test object does meet the requirement: P (Pass)</li> </ul>		
<ul> <li>test object does not meet the requirement: F (Fail)</li> </ul>		
Testing:		
Date of receipt of test item: 2020-04-30		
Date (s) of performance of tests: 2020-04-30 to 2020-05-11		
General remarks:		
"(See Enclosure #)" refers to additional information appended to the report. "(See appended table)" refers to a table appended to the report. Throughout this report a 🖂 comma / 🗌 point is used as the decimal separator.		
This document is issued by the Company subject to its General Conditions of Service, available on request or accessible at <u>http://www.sgs.com/en/Terms-and-Conditions.aspx</u> and, for electronic format documents, subject to Terms and Conditions for Electronic Documents at <u>http://www.sgs.com/en/Terms-and-Conditions/Terms-e-Document.aspx</u> . Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written ap- proval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are re- tained for 30 days only.		
Manufacturer's Declaration per sub-clause 4.2.5 of IECEE 02:		
The application for obtaining a CB Test Certificate in- cludes more than one factory location and a declaration from the Manufacturer stating that the sample(s) submit- ted for evaluation is (are) representative of the products from each factory has been provided		
When differences exist; they shall be identified in the General product information section.		

Name and address of factory (ies) .....:

#### General product information and other remarks:

- 1. The product can emit red and green light when powered.
- 2. The product GBX<sup>®</sup>-XXX<sup>®</sup> and MATE<sup>®</sup>-XXX<sup>®</sup> are identical on PCB layout, components used, internal wire and function, and only different on model name.
- 3. XX<sup>®</sup>: Consist of two letters from A to Z, representing the different destination of the product.

XXX<sup>2</sup>: Consist of three letters from A to Z, representing the serial number, which means separately the year, month and day of the producing date of the product.

X<sup>®</sup>: Consist of a letter from A to Z, representing the different destination of the product.

## Page 5 of 16 IEC 62471

Clause	
Clause	
• • • • • • •	

Requirement + Test

Result – Remark

4	EXPOSURE LIMITS		Р
4.1	General		Р
	The exposure limits in this standard is not less than 0,01 ms and not more than any 8-hour period and should be used as guides in the control of exposure		Р
	Detailed spectral data of a light source are generally required only if the luminance of the source exceeds $10^4 \text{ cd} \cdot \text{m}^{-2}$	see clause 4.3	Ρ
4.3	Hazard exposure limits		Р
4.3.1	Actinic UV hazard exposure limit for the skin and eye		Ρ
	The exposure limit for effective radiant exposure is 30 $J^{1}m^{-2}$ within any 8-hour period		Ρ
	To protect against injury of the eye or skin from ul- traviolet radiation exposure produced by a broad- band source, the effective integrated spectral irra- diance, E <sub>s</sub> , of the light source shall not exceed the levels defined by:		Ρ
	$E_{\rm s} \cdot t = \sum_{200}^{400} \sum_{t} E_{\lambda}(\lambda, t) \cdot S_{\rm UV}(\lambda) \cdot \Delta t \cdot \Delta \lambda \le 30 \qquad \qquad \text{J} \cdot \text{m}^{-2}$		Ρ
	The permissible time for exposure to ultraviolet ra- diation incident upon the unprotected eye or skin shall be computed by:		Р
	$t_{\max} = \frac{30}{E_s} \qquad s$		Р
4.3.2	Near-UV hazard exposure limit for eye		Р
	For the spectral region 315 nm to 400 nm (UV-A) the total radiant exposure to the eye shall not exceed 10000 J·m <sup>-2</sup> for exposure times less than 1000 s. For exposure times greater than 1000 s (approximately 16 minutes) the UV-A irradiance for the unprotected eye, E <sub>UVA</sub> , shall not exceed 10 W·m <sup>-2</sup> .		Ρ
	The permissible time for exposure to ultraviolet ra- diation incident upon the unprotected eye for time less than 1000 s, shall be computed by:		Ρ
	$t_{\max} \le \frac{10\ 000}{E_{\text{UVA}}} \qquad \text{s}$		Ρ
4.3.3	Retinal blue light hazard exposure limit	1	Р
	To protect against retinal photochemical injury from chronic blue-light exposure, the integrated spectral radiance of the light source weighted against the blue-light hazard function, $B(\lambda)$ , i.e., the blue-light weighted radiance, $L_B$ , shall not exceed the levels defined by:		Ρ
	$L_{B} \cdot t = \sum_{300}^{700} \sum_{t} L_{\lambda}(\lambda, t) \cdot B(\lambda) \cdot \Delta t \cdot \Delta \lambda \le 10^{6} \qquad J \cdot m^{-2} \cdot sr^{-1}$	for t ≤ 10 <sup>4</sup> s	N/A

Page 6 of 16

IEC 62471
-----------

Clause	Requirement + Test	Result – Remark	Verdict

	$L_{\rm B} = \sum_{300}^{700} L_{\lambda} \cdot B(\lambda) \cdot \Delta \lambda \le 100 \qquad \qquad {\rm W} \cdot {\rm m}^{-2} \cdot {\rm sr}^{-1}$	for t > 10 <sup>4</sup> s	P
4.3.4	Retinal blue light hazard exposure limit - small source	e	Р
	Thus the spectral irradiance at the eye $E_{\lambda}$ , weighted against the blue-light hazard function $B(\lambda)$ shall not exceed the levels defined by:	see table 4.2	Р
	$E_{\rm B} \cdot t = \sum_{300}^{700} \sum_{t} E_{\lambda}(\lambda, t) \cdot B(\lambda) \cdot \Delta t \cdot \Delta \lambda \le 100 \qquad \rm J \cdot m^{-2}$	for t ≤ 100 s	N/A
	$E_{\rm B} = \sum_{300}^{700} E_{\lambda} \cdot B(\lambda) \cdot \Delta \lambda \le 1 \qquad {\rm W} \cdot {\rm m}^{-2}$	for t > 100 s	P
4.3.5	Retinal thermal hazard exposure limit		Р
	To protect against retinal thermal injury, the inte- grated spectral radiance of the light source, $L_{\lambda}$ , weighted by the burn hazard weighting function $R(_{\lambda})$ (from Figure 4.2 and Table 4.2), i.e., the burn hazard weighted radiance, shall not exceed the levels de- fined by:		P
	$L_{R} = \sum_{380}^{1400} L_{\lambda} \cdot R(\lambda) \cdot \Delta \lambda \le \frac{50000}{\alpha \cdot t^{0,25}} \qquad W \cdot m^{-2} \cdot sr^{-1}$	(10 µs ≤ t ≤ 10 s)	Р
4.3.6	Retinal thermal hazard exposure limit – weak visual s	stimulus	N/A
	For an infrared heat lamp or any near-infrared source where a weak visual stimulus is inadequate to activate the aversion response, the near infrared (780 nm to 1400 nm) radiance, $L_{IR}$ , as viewed by the eye for exposure times greater than 10 s shall be limited to:		N/A
	$L_{\rm IR} = \sum_{780}^{1400} L_{\lambda} \cdot R(\lambda) \cdot \Delta \lambda \le \frac{6000}{\alpha} \qquad W \cdot {\rm m}^{-2} \cdot {\rm sr}^{-1}$	t > 10 s	N/A
4.3.7	Infrared radiation hazard exposure limits for the eye		N/A
	The avoid thermal injury of the cornea and possible delayed effects upon the lens of the eye (cataractogenesis), ocular exposure to infrared radiation, $E_{IR}$ , over the wavelength range 780 nm to 3000 nm, for times less than 1000 s, shall not exceed:		N/A
	$E_{\rm IR} = \sum_{780}^{3000} E_{\lambda} \cdot \Delta \lambda \le 18000 \cdot t^{-0,75} \qquad \rm W \cdot m^{-2}$	t ≤ 1000 s	N/A
	For times greater than 1000 s the limit becomes:		N/A
	$E_{\rm IR} = \sum_{780}^{3000} E_{\lambda} \cdot \Delta \lambda \le 100 \qquad \rm W \cdot m^{-2}$	t > 1000 s	N/A
4.3.8	Thermal hazard exposure limit for the skin		Р
	Visible and infrared radiant exposure (380 nm to 3000 nm) of the skin shall be limited to:		Р

### Page 7 of 16 مود . ۱**۳۵ 62471**

IEC	6247

Requirement + Test Clause

Result – Remark

	$E_{\rm H} \cdot t = \sum_{380}^{3000} \sum_{t} E_{\lambda}(\lambda, t) \cdot \Delta t \cdot \Delta \lambda \le 20000 \cdot t^{0,25} \qquad \rm{J} \cdot m^{-2}$	Р
5	MEASUREMENT OF LAMPS AND LAMP SYSTEMS	Р
5.1	Measurement conditions	Р
	Measurement conditions shall be reported as part of the evaluation against the exposure limits and the assignment of risk classification.	Р
5.1.1	Lamp ageing (seasoning)	N/A
	Seasoning of lamps shall be done as stated in the appropriate IEC lamp standard.	N/A
5.1.2	Test environment	Р
	For specific test conditions, see the appropriate IEC lamp standard or in absence of such standards, the appropriate national standards or manufacturer's recommendations.	P
5.1.3	Extraneous radiation	Р
	Careful checks should be made to ensure that ex- traneous sources of radiation and reflections do not add significantly to the measurement results.	Р
5.1.4	Lamp operation	Р
	Operation of the test lamp shall be provided in ac- cordance with:	Р
	<ul> <li>the appropriate IEC lamp standard, or</li> </ul>	N/A
	<ul> <li>the manufacturer's recommendation</li> </ul>	Р
5.1.5	Lamp system operation	Р
	The power source for operation of the test lamp shall be provided in accordance with:	Р
	<ul> <li>the appropriate IEC standard, or</li> </ul>	N/A
	<ul> <li>the manufacturer's recommendation</li> </ul>	Р
5.2	Measurement procedure	Р
5.2.1	Irradiance measurements	Р
	Minimum aperture diameter 7mm.	Р
	Maximum aperture diameter 50 mm.	Р
	The measurement shall be made in that position of the beam giving the maximum reading.	Р
	The measurement instrument is adequate calibrat- ed.	Р
5.2.2	Radiance measurements	Р
5.2.2.1	Standard method	Р
	The measurements made with an optical system.	Р
	The instrument shall be calibrated to read in abso- lute radiant power per unit receiving area and per	Р

# Page 8 of 16

IEC 62471	

Requirement + Test

Clause

Result – Remark

	unit solid angle to acceptance averaged over the field of view of the instrument.		
5.2.2.2	Alternative method		N/A
	Alternatively to an imaging radiance set-up, an irra- diance measurement set-up with a circular field stop placed at the source can be used to perform radi- ance measurements.		N/A
5.2.3	Measurement of source size		Р
	The determination of $\alpha$ , the angle subtended by a source, requires the determination of the 50% emission points of the source.		Р
5.2.4	Pulse width measurement for pulsed sources		N/A
	The determination of $\Delta t$ , the nominal pulse duration of a source, requires the determination of the time during which the emission is > 50% of its peak value.		N/A
5.3	Analysis methods		Р
5.3.1	Weighting curve interpolations		Р
	To standardize interpolated values, use linear in- terpolation on the log of given values to obtain in- termediate points at the wavelength intervals de- sired.	see table 4.1	Р
5.3.2	Calculations		Р
	The calculation of source hazard values shall be performed by weighting the spectral scan by the appropriate function and calculating the total weighted energy.		Р
5.3.3	Measurement uncertainty		Р
	The quality of all measurement results must be quantified by an analysis of the uncertainty.	see Annex C in the norm	Р
6	LAMP CLASSIFICATION		Р
	For the purposes of this standard it was decided that the values shall be reported as follows:	see table 6.1	Р
	<ul> <li>for lamps intended for general lighting service, the hazard values shall be reported as either irradiance or radiance values at a distance which produces an illuminance of 500 lux, but not at a distance less than 200 mm</li> </ul>		N/A
	<ul> <li>for all other light sources, including pulsed lamp sources, the hazard values shall be reported at a distance of 200 mm</li> </ul>		Р
6.1	Continuous wave lamps		Р
6.1.1	Exempt Group		Р
	In the exempt group are lamps, which does not pose any photobiological hazard. The requirement is met by any lamp that does not pose:		Р

		IEC 62471	· · · · · ·	
Clause	Requirement + Test		Result – Remark	Verdict

	<ul> <li>an actinic ultraviolet hazard (E<sub>s</sub>) within 8-hours exposure (30000 s), nor</li> </ul>	P
	<ul> <li>a near-UV hazard (E<sub>UVA</sub>) within 1000 s, (about 16 min), nor</li> </ul>	P
	– a retinal blue-light hazard ( $L_B$ ) within 10000 s (about 2,8 h), nor	Р
	- a retinal thermal hazard (L <sub>R</sub> ) within 10 s, nor	Р
	<ul> <li>an infrared radiation hazard for the eye (E<sub>IR</sub>)</li> <li>within 1000 s</li> </ul>	N/A
6.1.2	Risk Group 1 (Low-Risk)	N/A
	In this group are lamps, which exceeds the limits for the except group but that does not pose:	N/A
	<ul> <li>an actinic ultraviolet hazard (E<sub>s</sub>) within 10000 s, nor</li> </ul>	N/A
	– a near ultraviolet hazard (Euva) within 300 s, nor	N/A
	- a retinal blue-light hazard (L <sub>B</sub> ) within 100 s, nor	N/A
	– a retinal thermal hazard $(L_R)$ within 10 s, nor	N/A
	– an infrared radiation hazard for the eye ( $E_{IR}$ ) within 100 s	N/A
	Lamps that emit infrared radiation without a strong visual stimulus and do not pose a near-infrared retinal hazard ( $L_{IR}$ ), within 100 s are in Risk Group 1.	N/A
6.1.3	Risk Group 2 (Moderate-Risk)	N/A
	This requirement is met by any lamp that exceeds the limits for Risk Group 1, but that does not pose:	N/A
	<ul> <li>an actinic ultraviolet hazard (E<sub>s</sub>) within 1000 s exposure, nor</li> </ul>	N/A
	- a near ultraviolet hazard (E <sub>UVA</sub> ) within 100 s, nor	N/A
	– a retinal blue-light hazard ( $L_B$ ) within 0,25 s (aversion response), nor	N/A
	<ul> <li>a retinal thermal hazard (L<sub>R</sub>) within 0,25 s (aversion response), nor</li> </ul>	N/A
	<ul> <li>an infrared radiation hazard for the eye (E<sub>IR</sub>)</li> <li>within 10 s</li> </ul>	N/A
	Lamps that emit infrared radiation without a strong visual stimulus and do not pose a near-infrared retinal hazard ( $L_{IR}$ ), within 10 s are in Risk Group 2.	N/A
6.1.4	Risk Group 3 (High-Risk)	N/A
	Lamps which exceed the limits for Risk Group 2 are in Group 3.	N/A
6.2	Pulsed lamps	N/A
	Pulse lamp criteria shall apply to a single pulse and to any group of pulses within 0,25 s.	N/A

	1 490			001101
	IEC	62471		
Clause	Requirement + Test		Result – Remark	Verdict

		1	
	A pulsed lamp shall be evaluated at the highest nominal energy loading as specified by the manu- facturer.		N/A
1	The risk group determination of the lamp being tested shall be made as follows:		N/A
	<ul> <li>a lamp that exceeds the exposure limit shall be classified as belonging to Risk Group 3 (High-Risk)</li> </ul>		N/A
	<ul> <li>for single pulsed lamps, a lamp whose weighted radiant exposure or weighted radiance does is below the EL shall be classified as belonging to the Exempt Group</li> </ul>		N/A
	<ul> <li>for repetitively pulsed lamps, a lamp whose weighted radiant exposure or weighted radiance dose is below the EL, shall be evaluated using the continuous wave risk criteria discussed in clause 6.1, using time averaged values of the pulsed emission</li> </ul>		N/A

		Page 11 of 16	Report No: GZES20040 <sup>2</sup>	1654431
		IEC 62471		
Clause	Requirement + Test		Result – Remark	Verdict

Wavelength¹ λ, nm	UV hazard function S <sub>υν</sub> (λ)	Wavelength λ, nm	UV hazard functio S <sub>υν</sub> (λ)
200	0,030	313*	0,006
205	0,051	315	0,003
210	0,075	316	0,0024
215	0,095	317	0,0020
220	0,120	318	0,0016
225	0,150	319	0,0012
230	0,190	320	0,0010
235	0,240	322	0,00067
240	0,300	323	0,00054
245	0,360	325	0,00050
250	0,430	328	0,00044
254*	0,500	330	0,00041
255	0,520	333*	0,00037
260	0,650	335	0,00034
265	0,810	340	0,00028
270	1,000	345	0,00024
275	0,960	350	0,00020
280*	0,880	355	0,00016
285	0,770	360	0,00013
290	0,640	365*	0,00011
295	0,540	370	0,000093
297*	0,460	375	0,000077
300	0,300	380	0,000064
303*	0,120	385	0,000053
305	0,060	390	0,000044
308	0,026	395	0,000036
310	0,015	400	0,000030

Wavelengths chosen are representative: other values should be obtained by logarithmic interpolation at intermediate wavelengths.
 \* Emission lines of a mercury discharge spectrum.

Report No: GZES200401654431

Page 12 of 16	
---------------	--

	IEC 62471	
Clause	Requirement + Test	Result – Remark

Wavelength	Blue-light hazard function	Burn hazard functi
nm	Β (λ)	R (λ)
300	0,01	
305	0,01	
310	0,01	
315	0,01	
320	0,01	
325	0,01	
330	0,01	
335	0,01	
340	0,01	
345	0,01	
350	0,01	
355	0,01	
360	0,01	
365	0,01	
370	0,01	
375	0,01	
380	0,01	0,1
385	0,013	0,13
390	0,025	0,25
395	0,05	0,5
400	0,10	1,0
405	0,20	2,0
410	0,40	4,0
415	0,80	8,0
420	0,90	9,0
425	0,95	9,5
430	0,98	9,8
435	1,00	10,0
440	1,00	10,0
445	0,97	9,7
450	0,94	9,4
455	0,90	9,0
460	0,80	8,0
465	0,70	7,0
470	0,62	6,2
475	0,55	5,5
480	0,45	4,5
485	0,40	4,0
490	0,22	2,2
495	0,16	1,6
500-600	10[(450-λ)/50]	1,0
600-700	0,001	1,0
700-1050		10[(700-λ)/500]
1050-1150		0,2
1150-1200 1200-1400		0,2 <sup>.</sup> 10 <sup>0,02(1150-λ)</sup> 0,02

## Page 13 of 16

		IEC 62471		
Clause	Requirement + Test		Result – Remark	Verdict

Table 5.4         Summary of the ELs for the surface of the skin or cornea (irradiance based values)					ed values) P	
Hazard Name	Relevant equation		Wavelength range nm	Exposure duration sec	Limiting aperture rad (deg)	EL in terms of con- stant irradiance W•m <sup>-2</sup>
Actinic UV skin & eye		$E_{S} = \sum E_{\lambda} \bullet S(\lambda) \bullet \Delta \lambda$	200 – 400	< 30000	1,4 (80)	30/t
Eye UV-A		$E_{UVA} = \sum E_{\lambda} \bullet \Delta \lambda$	315 – 400	≤1000 >1000	1,4 (80)	10000/t 10
Blue-light small source	•	$E_{B} = \sum E_{\lambda} \bullet B(\lambda) \bullet \Delta \lambda$	300 – 700	≤100 >100	< 0,011	100/t 1,0
Eye IR		$E_{IR} = \sum E_{\lambda} \bullet \Delta \lambda$	780 –3000	≤1000 >1000	1,4 (80)	18000/t <sup>0,75</sup> 100
Skin therma	I	$E_{H} = \sum E_{\lambda} \bullet \Delta \lambda$	380 – 3000	< 10	2π sr	20000/t <sup>0,75</sup>

Table 5.5	Sur	Summary of the ELs for the retina (radiance based values)						
Hazard Na	me	Relevant equation	Wavelength range nm	Exposure duration sec	Field of view radians	EL in ter constant r W•m <sup>-2</sup> •	adiance	
Blue light		$L_B = \sum L_\lambda \bullet B(\lambda) \bullet \Delta \lambda$	300 – 700	0,25 – 10 10-100 100-10000 ≥ 10000	0,011•√(t/10) 0,011 0,0011•√t 0,1	10 <sup>6</sup> / 10 <sup>6</sup> / 10 <sup>6</sup> / 100	/t /t	
Retinal thermal		$L_{R} = \sum L_{\lambda} \bullet R(\lambda) \bullet \Delta \lambda$	380 – 1400	< 0,25 0,25 – 10	0,0017 0,011•√(t/10)	50000/(α 50000/(α	,	
Retinal thermal (weak visua stimulus)	I	$L_{IR} = \sum L_{\lambda} \bullet R(\lambda) \bullet \Delta \lambda$	780 – 1400	> 10	0,011	6000	/α	

Page 14 of 16

Report No: GZES200401654431

Table 6.1 (For Red light)	Emission limits for risk groups of continuous wave lamps							Р			
Risk	Action spectrum	Symbol	Units	Emission Measurement							
				Exempt		Low risk		Mod risk			
				Limit	Result	Limit	Result	Limit	Result		
Actinic UV	S <sub>υν</sub> (λ)	Es	W∙m⁻²	0,001	0	0,003		0,03			
Near UV		EUVA	W∙m⁻²	10	0	33	_	100			
Blue light	Β(λ)	L <sub>B</sub>	W•m⁻²•sr⁻¹	100	4,7 × 10 <sup>-3</sup>	10000		4000000			
Blue light, small source	Β(λ)	Ев	W∙m⁻²	1,0*	4,7 × 10 <sup>-5</sup>	1,0		400			
Retinal thermal	R(λ)	L <sub>R</sub>	W∙m <sup>-2</sup> •sr <sup>-1</sup>	28000/α	122,3	28000/α		71000/α			
Retinal thermal, weak visual stimu- lus**	R(λ)	L <sub>IR</sub>	W•m⁻²•sr⁻¹	6000/α	_	6000/α		6000/α			
IR radiation, eye		E <sub>IR</sub>	W•m <sup>-2</sup>	100	0	570		3200			
Skin thermal		Ен	W∙m⁻²	20000/t <sup>0.75</sup>			0,02	1	1		

\*\* Involves evaluation of non-GLS source.

Angular subtense of apparent source  $\alpha$  = 0,0017 radian.

Page 15 of 16

Report No: GZES200401654431

Table 6.1 (For Green light)	Emission limits for risk groups of continuous wave lamps							Р		
Risk	Action spectrum	Symbol	Units	Emission Measurement						
				Exempt		Low risk		Mod	Mod risk	
				Limit	Result	Limit	Result	Limit	Result	
Actinic UV	S <sub>υν</sub> (λ)	Es	W∙m⁻²	0,001	0	0,003		0,03		
Near UV	_	EUVA	W∙m⁻²	10	0	33		100		
Blue light	Β(λ)	LB	W•m⁻²•sr⁻¹	100	0,2	10000		4000000		
Blue light, small source	Β(λ)	Ев	W∙m⁻²	1,0*	2,9 × 10 <sup>-3</sup>	1,0		400		
Retinal thermal	R(λ)	L <sub>R</sub>	W•m⁻²•sr⁻¹	28000/α	253	28000/α		71000/α		
Retinal thermal, weak visual stimu- lus**	R(λ)	L <sub>IR</sub>	W•m⁻²•sr⁻¹	6000/α		6000/α		6000/α	_	
IR radiation, eye	_	Eir	W•m <sup>-2</sup>	100	0	570		3200		
Skin thermal	_	Ен	W•m⁻²	20000/t <sup>0.75</sup>			0,0	3		

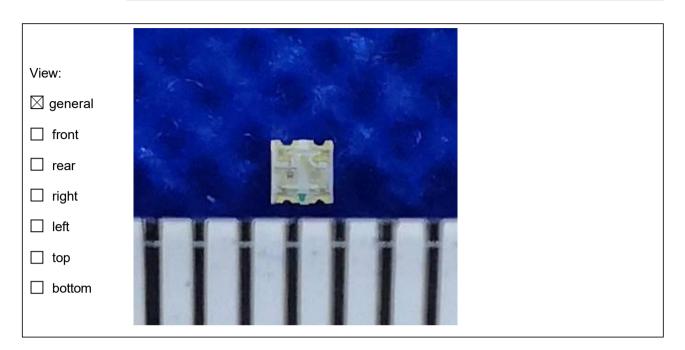
\*\* Involves evaluation of non-GLS source.

Angular subtense of apparent source  $\alpha$  = 0,0017 radian.

## Page 16 of 16 Attachment 1 : Photo documentation

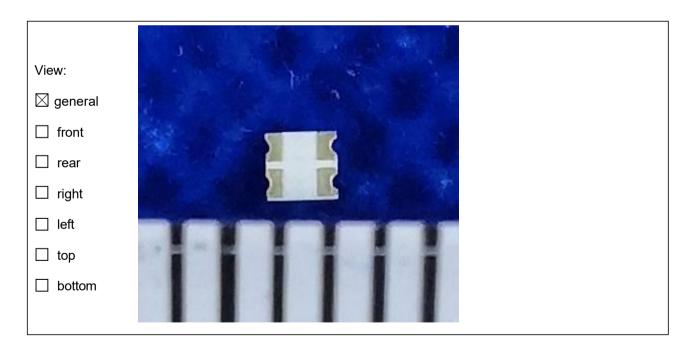
Details of:

View of product (For the MATE-XXX)



Details of:

View of product (For the MATE-XXX)



- End of report -